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(54) Title: IMPROVED METHOD FOR CHARACTERIZING LENSES

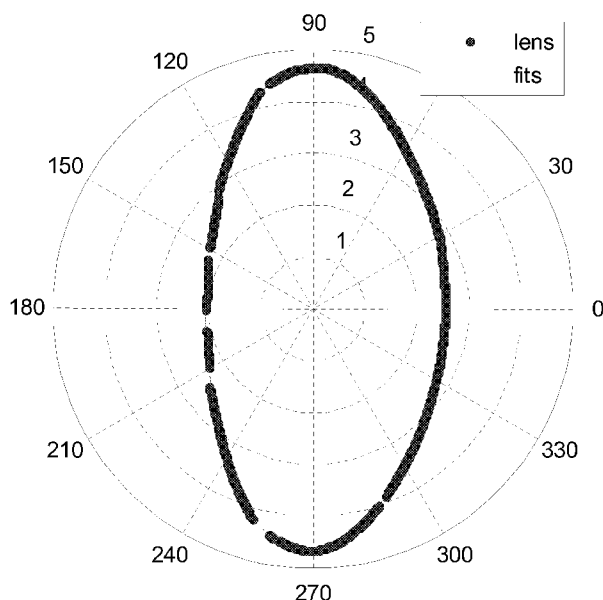


Figure 2

(57) Abstract: Methods are disclosed for characterizing an entire lens surface including anterior and posterior 'hemispheres' as well as the equatorial region as a single continuous mathematical representation by employing a summed serial function constituting incrementally higher orders of a base function and by utilizing a sufficiently high order of base function in the summation series to obtain the desired degree of accuracy of the representation.



ES, FI, FR, GB, GR, HR, HU, IE, IS, IT, LT, LU, LV,
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